

MOSFET

OptiMOS™3 Power-Transistor, 120 V

Features

- N-channel, normal level
- Excellent gate charge x  $R_{DS(on)}$  product (FOM)
- Very low on-resistance  $R_{DS(on)}$
- 150 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target application
- Ideal for high-frequency switching and synchronous rectification
- Halogen-free according to IEC61249-2-21



Table 1 Key Performance Parameters

| Parameter        | Value | Unit |
|------------------|-------|------|
| $V_{DS}$         | 120   | V    |
| $R_{DS(on),max}$ | 7.7   | mΩ   |
| $I_D$            | 98    | A    |



| Type / Ordering Code | Package    | Marking  | Related Links |
|----------------------|------------|----------|---------------|
| BSC077N12NS3 G       | PG-TDSON-8 | 077N12NS | -             |

<sup>1)</sup> J-STD20 and JESD22

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## 1 Maximum ratings

at  $T_A=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                           | Symbol            | Values |      |                  | Unit | Note / Test Condition                                                                            |
|-------------------------------------|-------------------|--------|------|------------------|------|--------------------------------------------------------------------------------------------------|
|                                     |                   | Min.   | Typ. | Max.             |      |                                                                                                  |
| Continuous drain current            | $I_D$             | -      | -    | 98<br>61<br>13.4 | A    | $T_C=25\text{ °C}$<br>$T_C=100\text{ °C}$<br>$T_A=25\text{ °C}$ , $R_{thJA}=45\text{ K/W}^{(1)}$ |
| Pulsed drain current <sup>(2)</sup> | $I_{D,pulse}$     | -      | -    | 392              | A    | $T_C=25\text{ °C}$                                                                               |
| Avalanche energy, single pulse      | $E_{AS}$          | -      | -    | 330              | mJ   | $I_D=50\text{ A}$ , $R_{GS}=25\text{ }\Omega$                                                    |
| Gate source voltage                 | $V_{GS}$          | -20    | -    | 20               | V    | -                                                                                                |
| Power dissipation                   | $P_{tot}$         | -      | -    | 139              | W    | $T_C=25\text{ °C}$                                                                               |
| Operating and storage temperature   | $T_j$ , $T_{stg}$ | -55    | -    | 150              | °C   | IEC climatic category;<br>DIN IEC 68-1: 55/150/56                                                |

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                                             | Symbol     | Values |      |      | Unit | Note / Test Condition |
|---------------------------------------------------------------------------------------|------------|--------|------|------|------|-----------------------|
|                                                                                       |            | Min.   | Typ. | Max. |      |                       |
| Thermal resistance, junction - case, bottom                                           | $R_{thJC}$ | -      | 0.5  | 0.9  | K/W  | -                     |
| Thermal resistance, junction - case, top                                              | $R_{thJC}$ | -      | -    | 18   | K/W  | -                     |
| Thermal resistance, junction - ambient, minimal footprint                             | $R_{thJA}$ | -      | -    | 75   | K/W  | -                     |
| Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>(1)</sup> | $R_{thJA}$ | -      | -    | 50   | K/W  | -                     |

<sup>1)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

<sup>2)</sup> see Diagram 3

### 3 Electrical characteristics

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |            |          | Unit          | Note / Test Condition                                                                                                                                         |
|----------------------------------|---------------|--------|------------|----------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.       | Max.     |               |                                                                                                                                                               |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 120    | -          | -        | V             | $V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$                                                                                                                       |
| Gate threshold voltage           | $V_{GS(th)}$  | 2      | 3          | 4        | V             | $V_{DS}=V_{GS}$ , $I_D=110\text{ }\mu\text{A}$                                                                                                                |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | 0.01<br>10 | 1<br>100 | $\mu\text{A}$ | $V_{DS}=100\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ }^\circ\text{C}$<br>$V_{DS}=100\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=125\text{ }^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | 1          | 100      | nA            | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                                                                                                                    |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 6.6        | 7.7      | m $\Omega$    | $V_{GS}=10\text{ V}$ , $I_D=50\text{ A}$                                                                                                                      |
| Gate resistance <sup>1)</sup>    | $R_G$         | -      | 1          | 1.5      | $\Omega$      | -                                                                                                                                                             |
| Transconductance                 | $g_{fs}$      | 40     | 80         | -        | S             | $ V_{DS} >2 I_D R_{DS(on)max}$ , $I_D=50\text{ A}$                                                                                                            |

**Table 5 Dynamic characteristics<sup>1)</sup>**

| Parameter                    | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                              |
|------------------------------|--------------|--------|------|------|------|----------------------------------------------------------------------------------------------------|
|                              |              | Min.   | Typ. | Max. |      |                                                                                                    |
| Input capacitance            | $C_{iss}$    | -      | 4300 | 5700 | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=60\text{ V}$ , $f=1\text{ MHz}$                                      |
| Output capacitance           | $C_{oss}$    | -      | 550  | 730  | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=60\text{ V}$ , $f=1\text{ MHz}$                                      |
| Reverse transfer capacitance | $C_{rss}$    | -      | 28   | 49   | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=60\text{ V}$ , $f=1\text{ MHz}$                                      |
| Turn-on delay time           | $t_{d(on)}$  | -      | 15   | -    | ns   | $V_{DD}=60\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=25\text{ A}$ ,<br>$R_{G,ext}=2.7\text{ }\Omega$ |
| Rise time                    | $t_r$        | -      | 8    | -    | ns   | $V_{DD}=60\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=25\text{ A}$ ,<br>$R_{G,ext}=2.7\text{ }\Omega$ |
| Turn-off delay time          | $t_{d(off)}$ | -      | 26   | -    | ns   | $V_{DD}=60\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=25\text{ A}$ ,<br>$R_{G,ext}=2.7\text{ }\Omega$ |
| Fall time                    | $t_f$        | -      | 7    | -    | ns   | $V_{DD}=60\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=25\text{ A}$ ,<br>$R_{G,ext}=2.7\text{ }\Omega$ |

**Table 6 Gate charge characteristics<sup>2)</sup>**

| Parameter                       | Symbol        | Values |      |      | Unit | Note / Test Condition                                                       |
|---------------------------------|---------------|--------|------|------|------|-----------------------------------------------------------------------------|
|                                 |               | Min.   | Typ. | Max. |      |                                                                             |
| Gate to source charge           | $Q_{gs}$      | -      | 21   | -    | nC   | $V_{DD}=60\text{ V}$ , $I_D=25\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge            | $Q_{gd}$      | -      | 15   | -    | nC   | $V_{DD}=60\text{ V}$ , $I_D=25\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Switching charge                | $Q_{sw}$      | -      | 29   | -    | nC   | $V_{DD}=60\text{ V}$ , $I_D=25\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total <sup>1)</sup> | $Q_g$         | -      | 66   | 88   | nC   | $V_{DD}=60\text{ V}$ , $I_D=25\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate plateau voltage            | $V_{plateau}$ | -      | 4.7  | -    | V    | $V_{DD}=60\text{ V}$ , $I_D=25\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Output charge <sup>1)</sup>     | $Q_{oss}$     | -      | 76   | 100  | nC   | $V_{DD}=60\text{ V}$ , $V_{GS}=0\text{ V}$                                  |

<sup>1)</sup> Defined by design. Not subject to production test.

<sup>2)</sup> See "Gate charge waveforms" for parameter definition.

**Table 7 Reverse diode**

| Parameter                             | Symbol        | Values |      |      | Unit | Note / Test Condition                                             |
|---------------------------------------|---------------|--------|------|------|------|-------------------------------------------------------------------|
|                                       |               | Min.   | Typ. | Max. |      |                                                                   |
| Diode continuous forward current      | $I_S$         | -      | -    | 98   | A    | $T_C=25\text{ °C}$                                                |
| Diode pulse current                   | $I_{S,pulse}$ | -      | -    | 392  | A    | $T_C=25\text{ °C}$                                                |
| Diode forward voltage                 | $V_{SD}$      | -      | 0.9  | 1.2  | V    | $V_{GS}=0\text{ V}$ , $I_F=50\text{ A}$ , $T_j=25\text{ °C}$      |
| Reverse recovery time <sup>1)</sup>   | $t_{rr}$      | -      | 98   | -    | ns   | $V_R=60\text{ V}$ , $I_F=25$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge <sup>1)</sup> | $Q_{rr}$      | -      | 264  | -    | nC   | $V_R=60\text{ V}$ , $I_F=25$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |

<sup>1)</sup> Defined by design. Not subject to production test.

## 4 Electrical characteristics diagrams

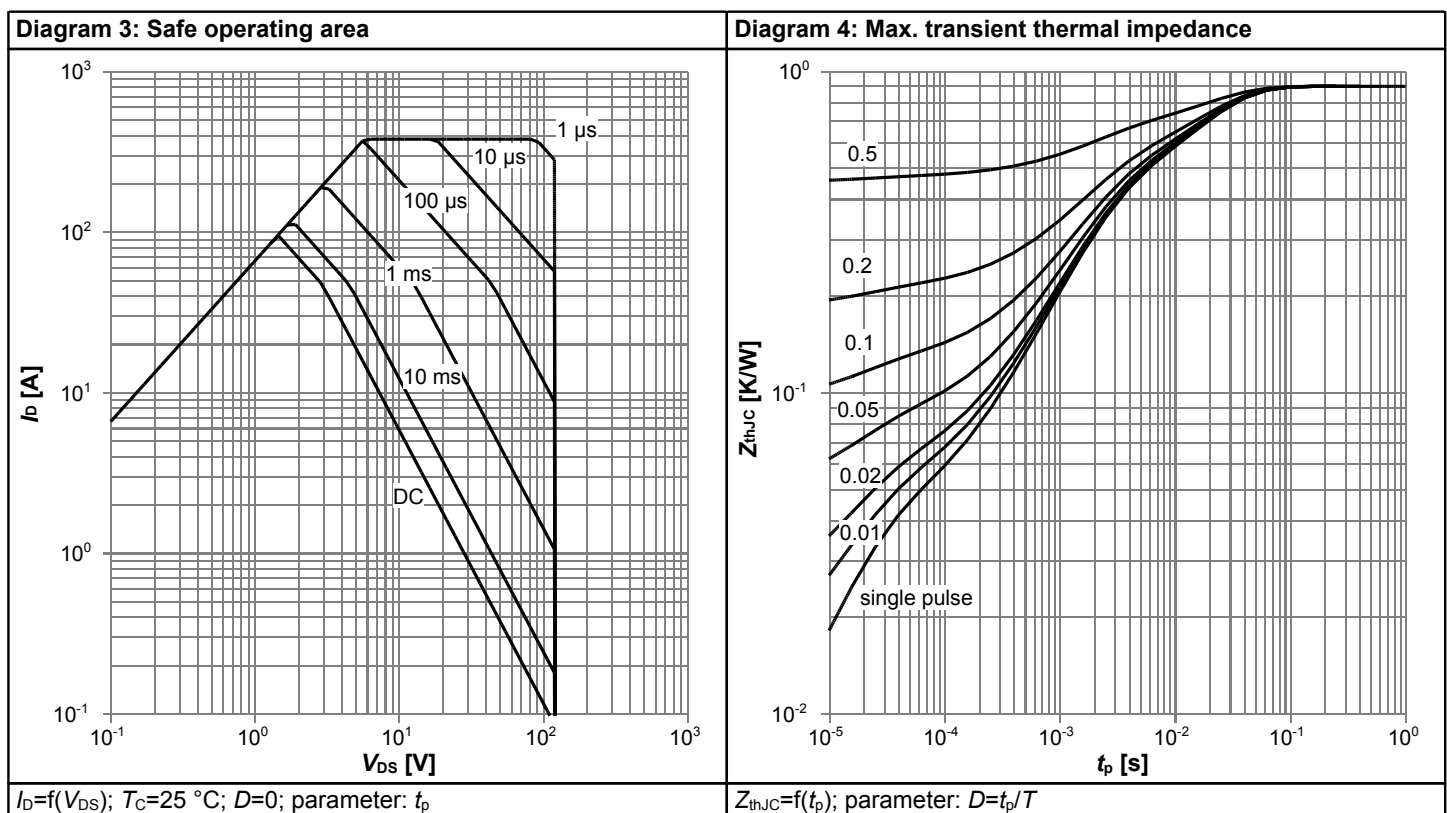
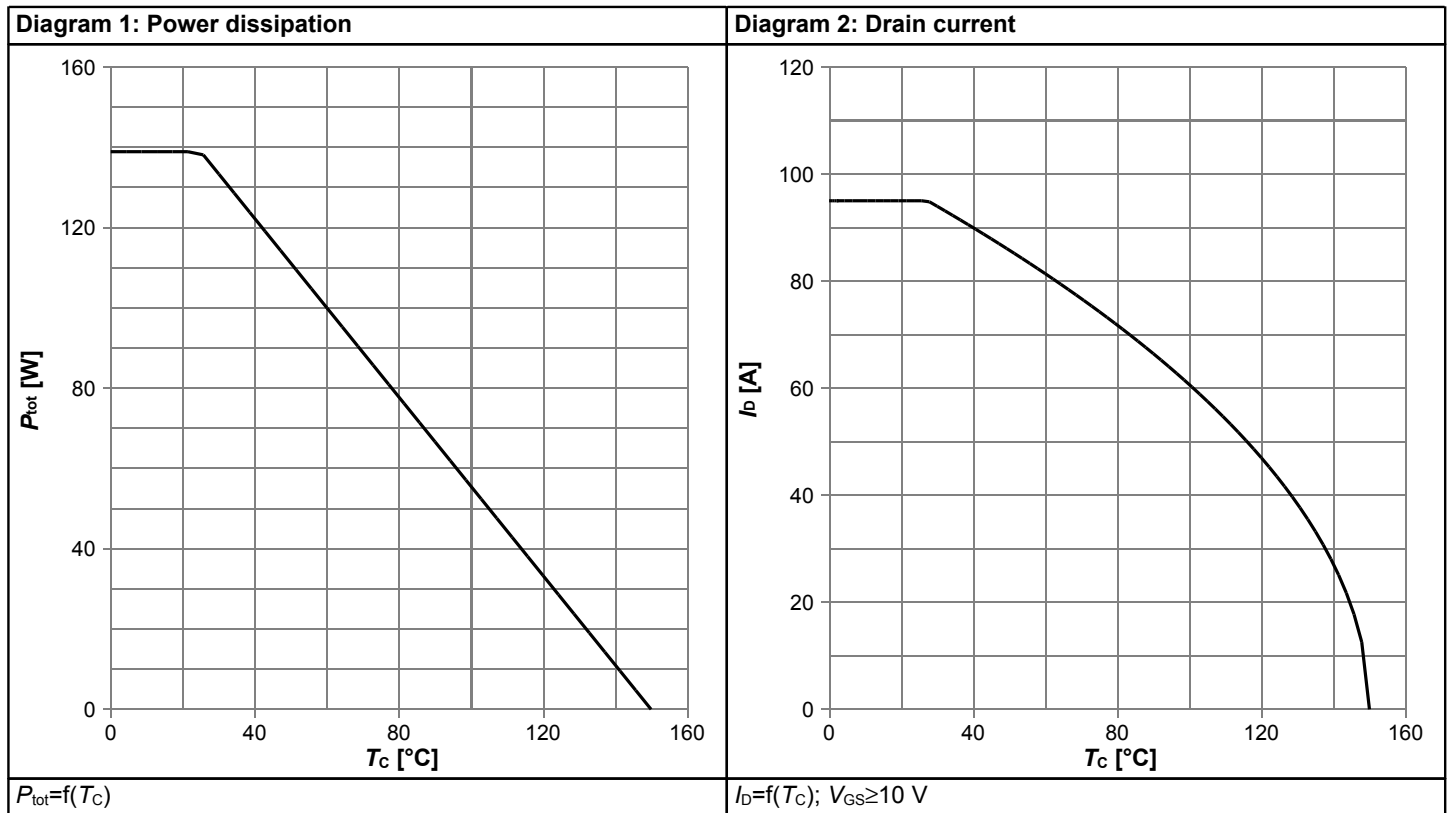
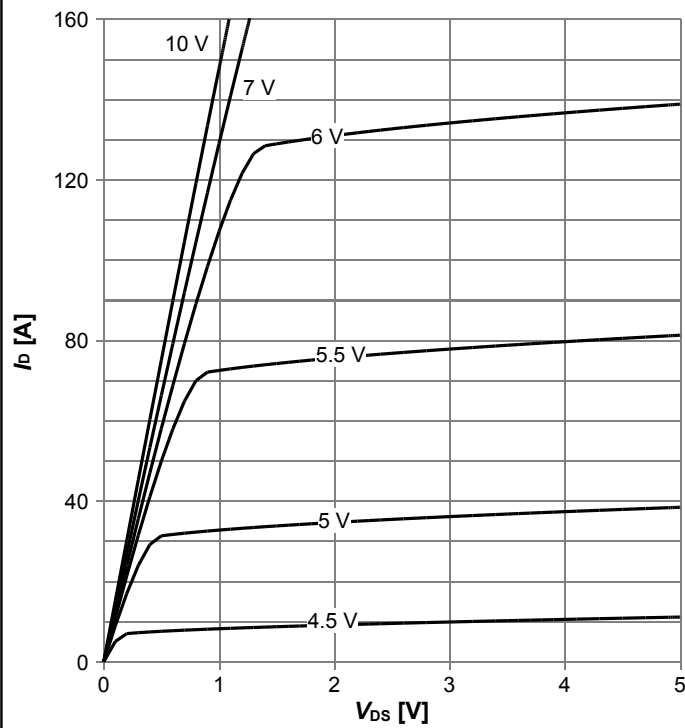
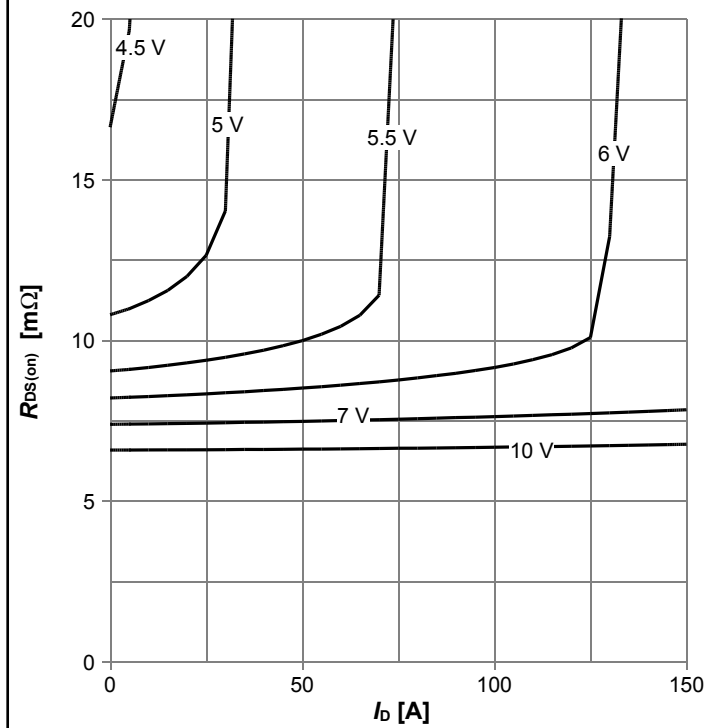


Diagram 5: Typ. output characteristics



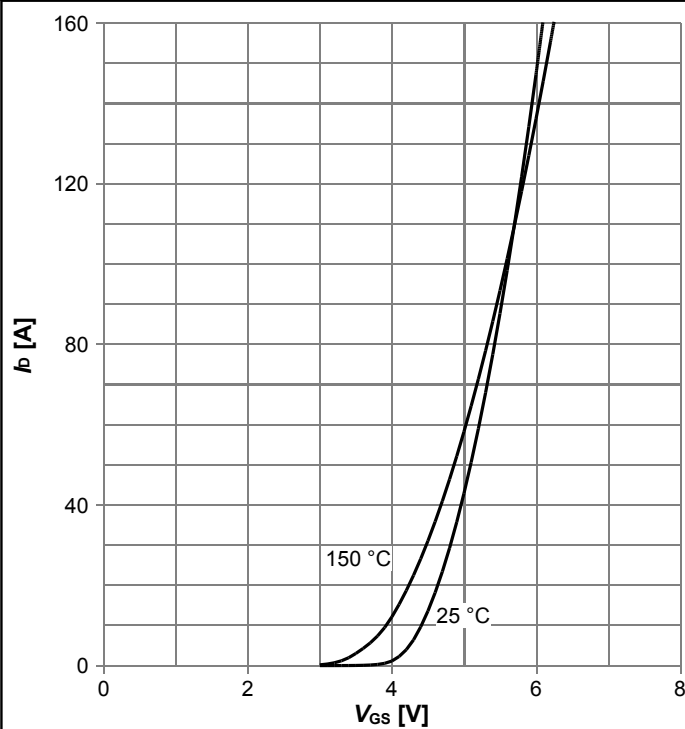
$I_D = f(V_{DS})$ ;  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. drain-source on resistance



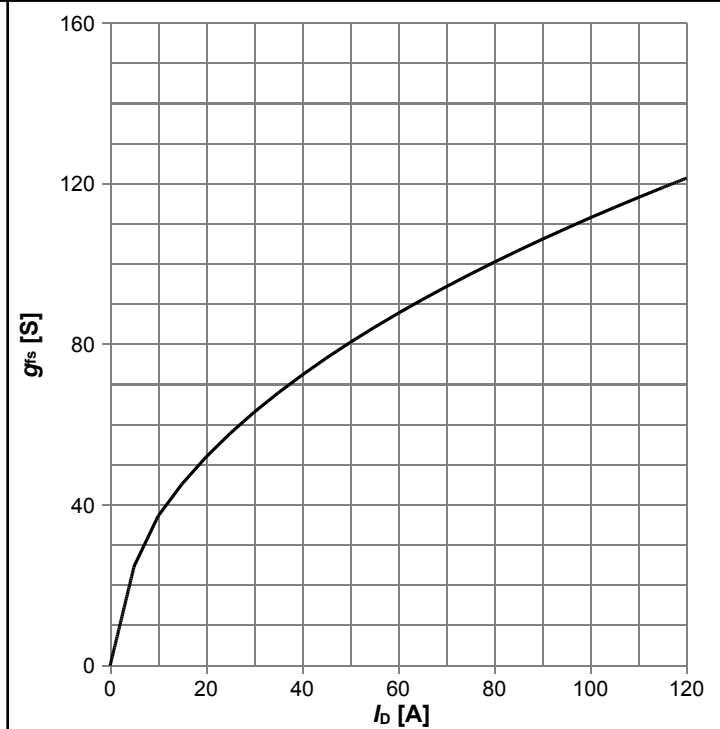
$R_{DS(on)} = f(I_D)$ ;  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. transfer characteristics



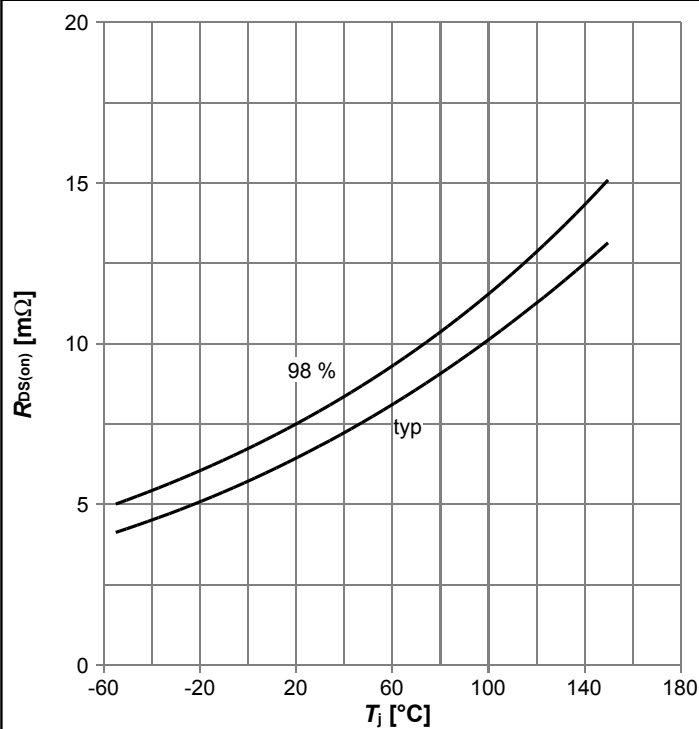
$I_D = f(V_{GS})$ ;  $|V_{DS}| > 2|I_D|R_{DS(on)max}$ ; parameter:  $T_j$

Diagram 8: Typ. forward transconductance



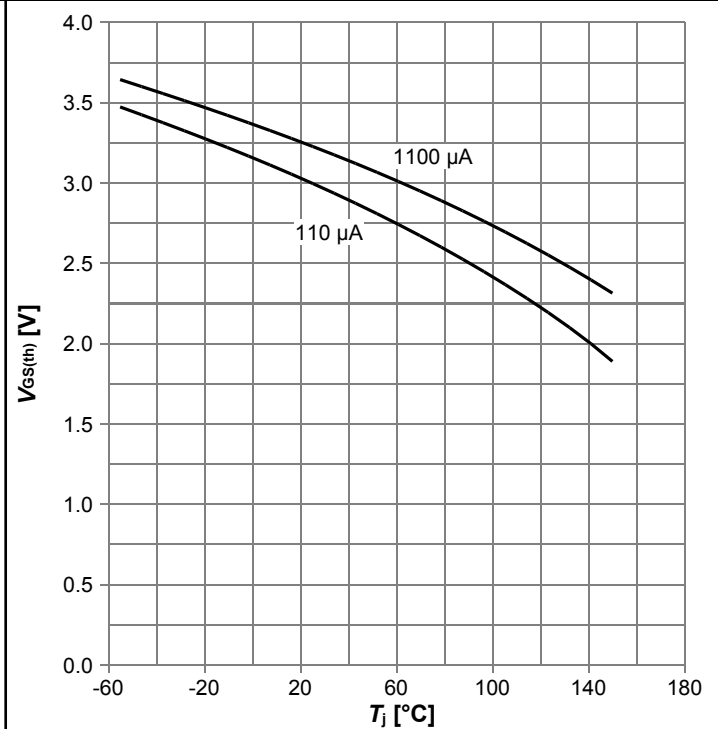
$g_{fs} = f(I_D)$ ;  $T_j = 25^\circ\text{C}$

Diagram 9: Drain-source on-state resistance



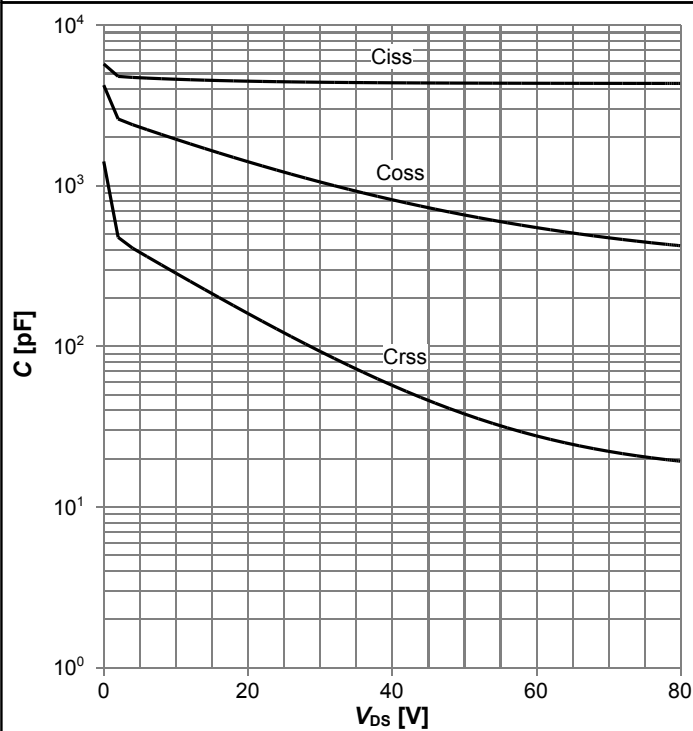
$R_{DS(on)} = f(T_j)$ ;  $I_D = 50 \text{ A}$ ;  $V_{GS} = 10 \text{ V}$

Diagram 10: Typ. gate threshold voltage



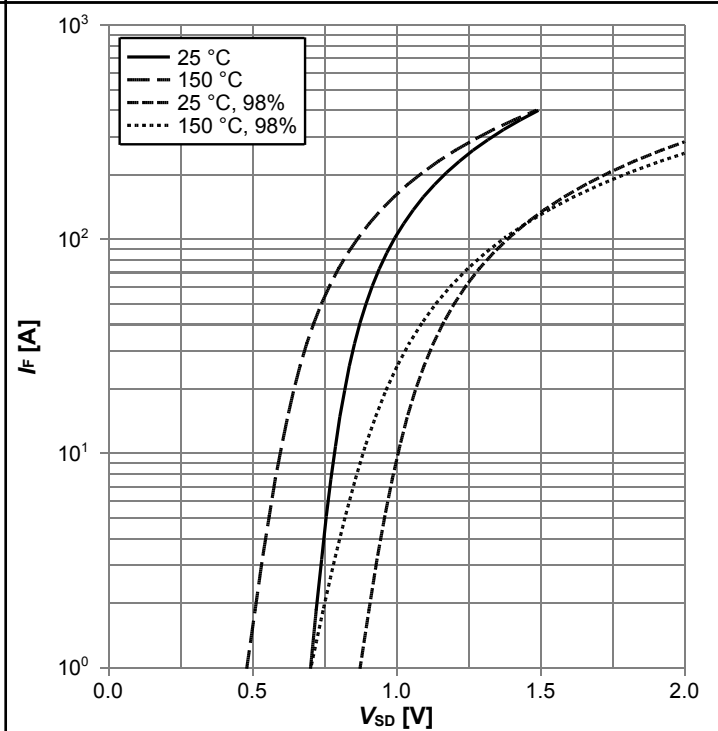
$V_{GS(th)} = f(T_j)$ ;  $V_{GS} = V_{DS}$ ; parameter:  $I_D$

Diagram 11: Typ. capacitances



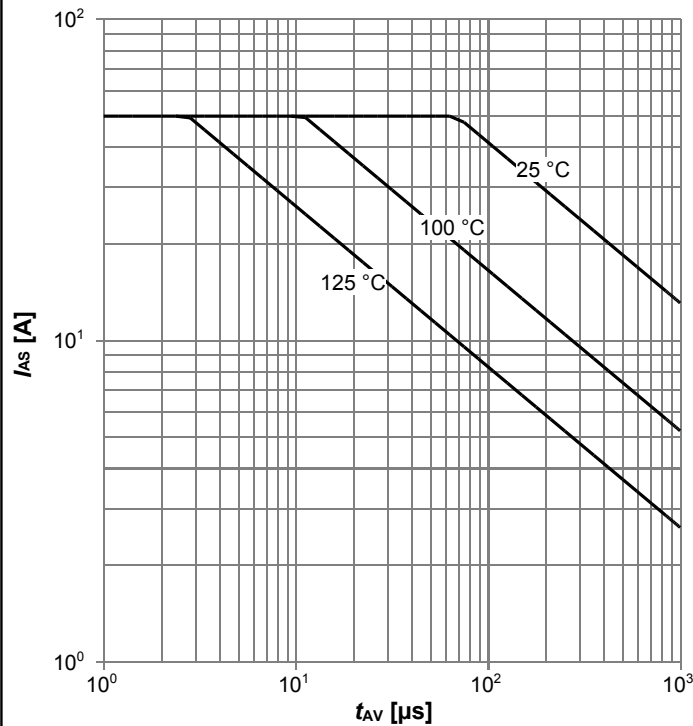
$C = f(V_{DS})$ ;  $V_{GS} = 0 \text{ V}$ ;  $f = 1 \text{ MHz}$

Diagram 12: Forward characteristics of reverse diode



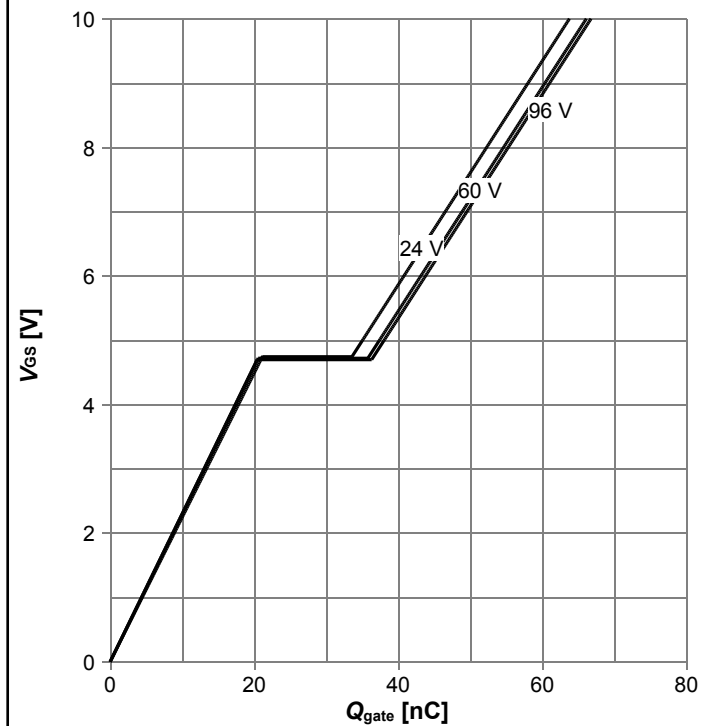
$I_F = f(V_{SD})$ ; parameter:  $T_j$

Diagram 13: Avalanche characteristics



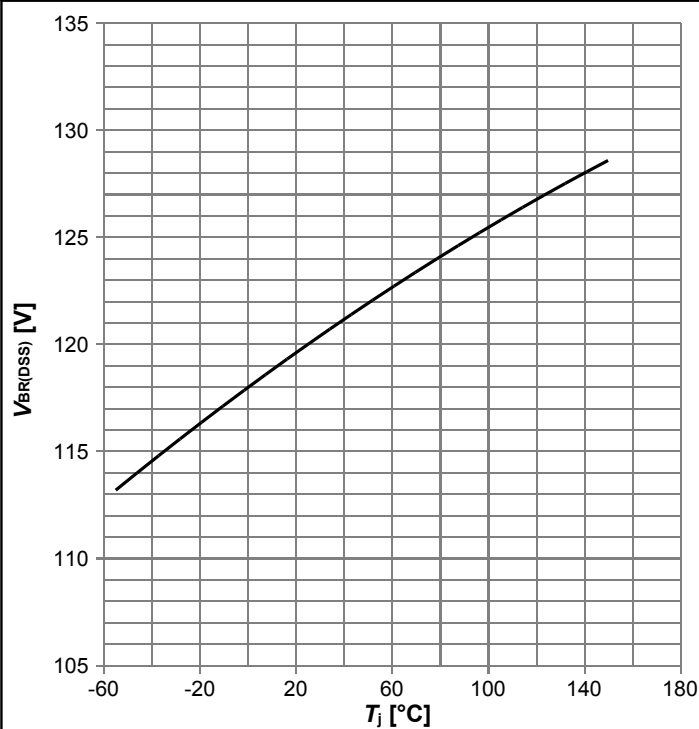
$I_{AS}=f(t_{AV})$ ;  $R_{GS}=25\ \Omega$ ; parameter:  $T_{j(start)}$

Diagram 14: Typ. gate charge



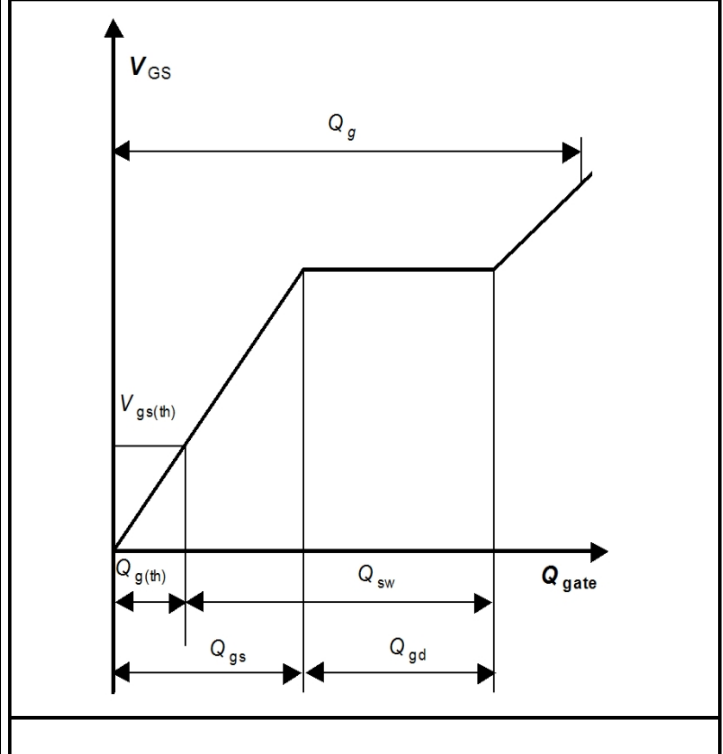
$V_{GS}=f(Q_{gate})$ ;  $I_D=25\text{ A}$  pulsed; parameter:  $V_{DD}$

Diagram 15: Drain-source breakdown voltage



$V_{BR(DSS)}=f(T_j)$ ;  $I_D=1\text{ mA}$

Gate charge waveforms



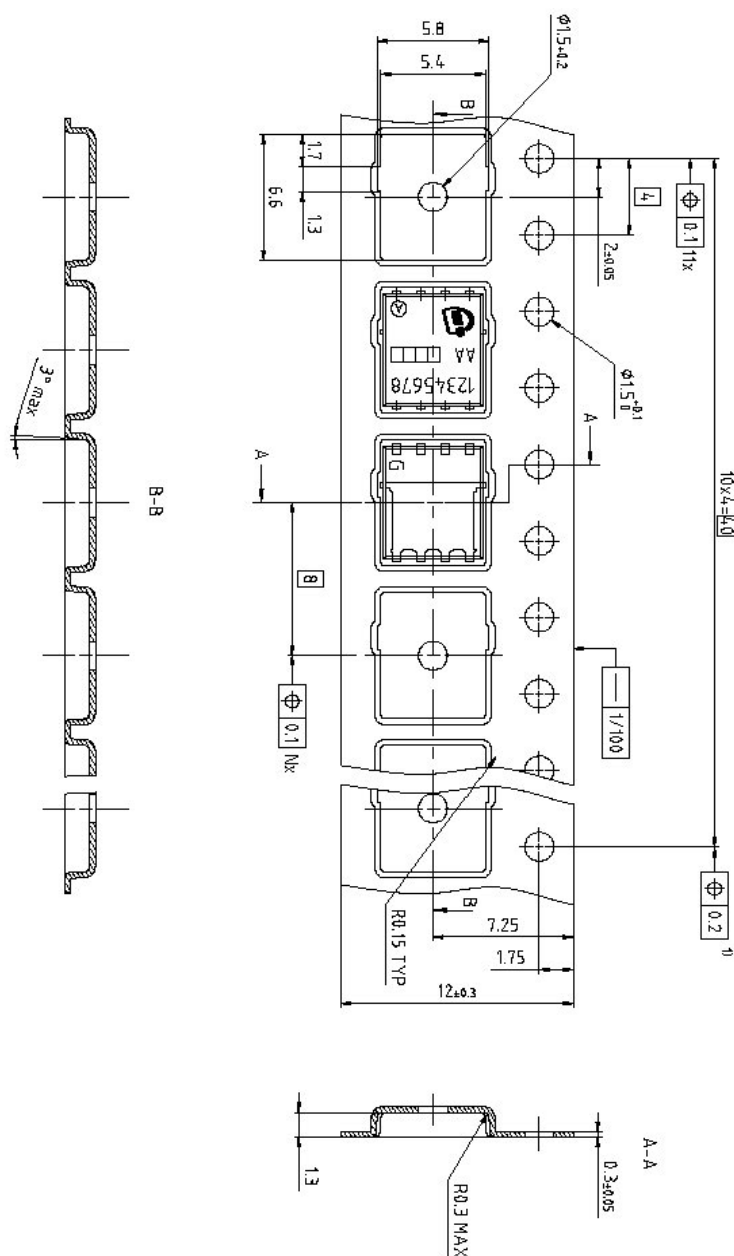
## 5 Package Outlines



| DIM   | MILLIMETERS |      |
|-------|-------------|------|
|       | MIN         | MAX  |
| A     | 0.90        | 1.10 |
| b     | 0.31        | 0.54 |
| b1    | 0.02        | 0.22 |
| c     | 0.15        | 0.35 |
| D     | 5.15        | 5.49 |
| D1    | 4.95        | 5.35 |
| D2    | 3.70        | 4.40 |
| E     | 5.95        | 6.35 |
| E1    | 5.70        | 6.10 |
| E2    | 3.40        | 3.80 |
| e     | 1.27        |      |
| N     | 8           |      |
| L     | 0.45        | 0.71 |
| M     | 0.45        | 0.75 |
| theta | 8.5°        | 12°  |
| aaa   | 0.25        |      |
| eee   | 0.08        |      |

|                                    |
|------------------------------------|
| <b>DOCUMENT NO.</b><br>Z8B00003332 |
| <b>SCALE</b><br>0 2 4mm            |
| <b>EUROPEAN PROJECTION</b><br>     |
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| <b>REVISION</b><br>04              |

Figure 1 Outline PG-TDSON-8, dimensions in mm



Dimension in mm

Figure 2 Outline TDSON-8 Tape



**Figure 3** Outline Footprint TDSON-8

## Revision History

BSC077N12NS3 G

**Revision: 2015-12-15, Rev. 2.8**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision)         |
|----------|------------|------------------------------------------------------|
| 2.7      | 2014-10-02 | Rev. 2.7                                             |
| 2.8      | 2015-12-15 | Update of dynamic parameters td(on), td(off), tr, tf |

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